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PTO/SB/08A (08-00)

Approved for use through 10/31/2002. OMB 0651-0031

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Substitute for form 1449A/PTO				Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)				Application Number	
				Filing Date	
				First Named Inventor	
				Group Art Unit	
				Examiner Name	
Sheet	1	of	2	Attorney Docket Number	

1c903 U.S. PTO
09/902622
07/12/01

U.S. PATENT DOCUMENTS						
Examiner Initials ¹	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code ² (if known)			
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		Office ³	Number ⁴	Kind Code ⁵ (if known)			
2406-95		Japan	04-282869			10/07/1992	Abstract
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2406-95		Japan	05-107558			04/30/1993	Full
		Examiner Signature: A. Blackman				Date Considered: 2/21/2002	

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¹ Unique citation designation number. ² See attached Kinds of U.S. Patent Documents. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)				Application Number								
				Filing Date		July 12, 2001						
				First Named Inventor		Jun KOYAMA et al.						
				Group Art Unit		2672						
				Examiner Name		A. Blackman						
Sheet		2		of		2		Attorney Docket Number		740756-2339		
U.S. PATENT DOCUMENTS												
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			Number	Kind Code ² (if known)								
FOREIGN PATENT DOCUMENTS												
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OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS												
Examiner Initials*		Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.									T ²
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Form PTO-1449
(Rev. 8-83)U.S. Department of Commerce
Patent and Trademark Office

Atty Docket 0756-233

Serial No. 09/002,622


INFORMATION DISCLOSURE STATEMENT

Applicants: Jun KOYAMA et al.

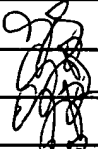



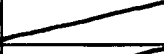

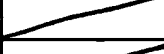


Filing Date: July 12, 2001

Group Art Unit: 2672

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